

Notice of References Cited	Application/Control No. 10/723,117	Applicant(s)/Patent Under Reexamination GU ET AL.	
	Examiner Kaj K Olsen	Art Unit 1753	Page 1 of 1

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	B	US-5,466,348	11-1995	Holm-Kennedy, James W.	205/775
	C	US-5,156,972	10-1992	Issachar, David	422/68.1
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NON-PATENT DOCUMENTS

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	V	Kong et al, Science, vol. 287, January 2000, pp. 622-625.
	W	Krstic et al, Electronic Properties of Novel Materials-Molecular Nanostructures, 2000, pp. 367-370.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.